

TITLE OF THE INVENTION

SOLID IMAGE-PICKUP DEVICE AND METHOD OF MANUFACTURING
THE SAME

CROSS-REFERENCE TO RELATED APPLICATIONS

5 This application is based upon and claims the benefit of priority from the prior Japanese Patent Application No. 2000-017329, filed January 26, 2000, the entire contents of which are incorporated herein by reference.

10 BACKGROUND OF THE INVENTION

The present invention relates to a solid image-pickup device represented by a C-MOS, a CCD, etc. and a method of manufacturing the same, particularly, to a solid image-pickup device that permits improving the sensitivity and suppressing the smear by increasing the effective opening rate of a micro lens and a method of manufacturing the same.

15 The solid image-pickup device comprises the regions contributing to passing the light through the light receiving element and opto-electric conversion, hereinafter referred to each of the regions as "open portion". In general, the sensitivity of the light receiving element depends on the size of the open portion. In other words, the small open portion leads to a low sensitivity. The open portion of the light receiving element such as a CCD is limited to about 20 to 40% of the entire area of the element. In general,

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the sensitivity is increased by forming a micro lens
with height opening rate on a light receiving element,
in addition to the measure for increasing the open
portion as much as possible, because the micro lens
5 with height opening rate improves the light collection.

Note that opening rate of a lens is defined as the
ratio of the area of the plan view of a micro lens to
the square of the pitch between the adjacent micro
lenses.

10 In recent years, a high precision solid image-
pickup device having more than 2,000,000 pixels is
being propagated. In such a high precision solid
image-pickup device, plurality of miniaturized light
receiving elements are arranged densely. Consequently,
15 the reduction of the opening rate based on the
miniaturization of the light receiving element and the
reduction in sensitivity accompanying the reduction in
the opening rate are prominent.

As described above, the micro lens is useful means
20 to improve the opening rate of the solid image-pickup
device. The high precision solid image-pickup device
having more than 2,000,000 pixels requires the
arrangement of the micro lenses at a pitch not larger
than $5 \mu\text{m}$ and not larger than $0.3 \mu\text{m}$ of the gap
25 between the adjacent micro lenses, hereinafter referred
to as "a lens gap". However, the micro lens is formed
in general by utilizing in combination the

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photolithography using a photosensitive resin and a heat flow technology. Because of the restrictions of these technologies, the lens gap in the side direction of the micro lens is about 1 μm to at most about 5 0.4 μm . If the lens gap is made 0.3 μm or less in heat flow process, the adjacent micro lenses are connected to each other at the lens edge and the nonuniformity of the photosensitive resin tends to occur, resulting in failure to provide a stable 10 production technology of a mass production level. The restrictions inherent in the prior art described above lead to the lens gap larger than 0.3 μm . That is, it is one of the important subjects that the reduction in the opening rate of the micro lens accompanying the 15 high precision of the solid image-pickup device, in other words, the sensitivity of the solid image-pickup device is lowered.

Concerning conventional formation of the micro lens, various technologies are disclosed in, for 20 example, Japanese Patent Disclosure (Kokai) No. 60-53073 and Japanese Patent Disclosure No. 5-48057. The technology of the formation of the micro lens disclosed therein is following.

Japanese Patent Disclosure No. 60-53073 discloses 25 the technology of forming a lens hemispherical by utilizing the heat flowability (heat flow) of resin caused by the heat flow. Also disclosed in detail is

the technology of working a lens by some etching technologies. In addition, disclosed is formation of an organic film such as PGMA and an inorganic film such as OCD (SiO₂ series) on the lens surface.

5 Each of Japanese Patent Disclosure No. 5-48057 and Japanese Patent Disclosure No. 60-53073 discloses the technology of laminating a thin film on a resin lens, said thin film differing from the lens material in the refractive index. Specifically, Japanese Patent
10 Disclosure No. 5-48057 discloses the depositing method using CVD of, for example, ECR plasma, the method isotropically depositing an inorganic film or a resin film on a resin lens to perform a small gap between lenses and improve the opening rate of the lenses. In
15 general, the method of synthetic vapor deposition for depositing, for example, a urea resin by using a vapor deposition machine is also useful to perform a small gap between lenses.

However, these prior arts necessitate a costly
20 vacuum apparatus and a CVD apparatus and are not simple process, leading to a marked increase in the manufacturing cost.

As a stable production technology capable of improving the light collection or as a production
25 technology capable of forming the shape between the adjacent micro lenses, Japanese Patent Disclosure No. 60-53073 referred to previously, Japanese Patent

Disclosure No. 6-112459 and Japanese Patent Disclosure No. 9-45884 disclose a technology called trench system utilizing an etching. These technologies certainly make it possible to product a concave lens by forming a concave portion between adjacent micro lenses and the edge of the concave portion circular.

However, in the trench system, it is difficult to form a small gap between the adjacent micro lenses not larger than 0.3 μm . This is the reason why the trench system is the technology to form a concave portion by etching such as a dry etching with a micro lens used as a matrix, the lens is basically shaped moderate and, at the same time, the etching is performed such that the concave portion is widened. In other words, the trench system is not basically directed to the technology in such a manner to perform the small gap between the adjacent micro lenses by etching such as a isotropic etching or an anisotropic etching with a micro lens used as a matrix.

BRIEF SUMMARY OF THE INVENTION

An object of the present invention, which has been achieved in view of the above-noted problems inherent in the prior art, is to provide a solid image-pickup device comprising high opening rate micro lenses and the gap between the adjacent the micro lenses and a method of manufacturing the same.

According to a first aspect of the present

invention, there is provided a solid image-pickup device, comprising: a micro lens array formed by arranging a plurality of resin lenses in a manner to form a matrix; an undercoat layer for fixing the micro lens array and having a ditch formed between the adjacent resin lenses; and a transparent resin layer covering the plural resin lenses with substantially the same thickness and the ditch between the adjacent resin lenses.

According to a second aspect of the present invention, there is provided a solid image-pickup device, comprising: a micro lens array formed by arranging a plurality of resin lenses in a manner to form a matrix; an undercoat layer for fixing the micro lens array and having a ditch formed between adjacent micro lenses not larger than $0.3 \mu\text{m}$; and a transparent resin layer covering the plural resin lenses and the ditch, wherein the difference between the height of the surface of the transparent layer in the ditch in the diagonal direction of the lens array and the height of the tops of micro lenses each consisting of the resin lens and the transparent resin layer covering the surface of the resin lens is larger than the difference between the height of the surface of the transparent layer in the ditch in the arranging direction of the lens array and the height of the top of the micro lens.

According to a third aspect of the present

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invention, there is provided a method of manufacturing
a solid image-pickup device, comprising the steps of:
forming a photosensitive resin layer on an undercoat
layer; exposing the photosensitive resin layer to light
5 in a predetermined pattern, followed by a developing
treatment so as to form a resin pattern layer having a
predetermined gap width; subjecting the resin pattern
layer to a heat flow so as to form resin lenses;
applying an etching treatment to those portions of the
10 undercoat layer which are exposed in regions between
adjacent resin lenses to form ditches; and forming a
transparent resin layer on the surfaces of the resin
lenses and the undercoat layer.

According to the construction defined in the
15 present invention, it is possible to provide a solid
image-pickup device comprising high opening rate micro
lenses and the gap not larger than $0.3 \mu\text{m}$ between the
adjacent the micro lenses and a method of manufacturing
the same. In addition, it is possible to improve the
20 light collecting effect in the diagonal direction of
the micro lens array and to eliminate the lowering of
the characteristics of the solid image pickup element
caused by the light reflection in the flat portion
between the micro lenses in the diagonal direction. As
25 a result, it is possible to provide a solid image
pickup element capable of improving the sensitivity and
suppressing the smear.

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Additional objects and advantages of the invention will be set forth in the description which follows, and in part will be obvious from the description, or may be learned by practice of the invention. The objects and 5 advantages of the invention may be realized and obtained by means of the instrumentalities and combinations particularly pointed out hereinafter.

BRIEF DESCRIPTION OF THE SEVERAL VIEWS OF THE DRAWING

The accompanying drawings, which are incorporated 10 in and constitute a part of the specification, illustrate presently preferred embodiments of the invention, and together with the general description given above and the detailed description of the preferred embodiments given below, serve to explain the 15 principles of the invention.

FIG. 1 is a plan view partly showing a solid image-pickup device according to one embodiment of the present invention;

20 FIG. 2 is a cross sectional view schematically showing the solid image-pickup device along the line A-A shown in FIG. 1;

FIG. 3A is a cross sectional view along the line B-B shown in FIG. 1;

25 FIG. 3B is a cross sectional view along the line C-C shown in FIG. 1; and

FIGS. 4A to 4E are cross sectional views collectively showing a method according to one

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embodiment of the present invention of manufacturing a solid image-pickup device of the present invention.

DETAILED DESCRIPTION OF THE INVENTION

Some embodiments of the present invention will now
5 be described with reference to the accompanying
drawings. In the following description, the
constituents of the present invention having
substantially the same function and construction are
denoted by the same reference numerals so as to avoid
10 an overlapping description, though an overlapping
description is repeated where necessary.

First of all, the construction of a solid image-
pickup device of the present invention will be
described with reference to the accompanying drawings.

15 FIG. 1 is plan view showing a part of a solid
image-pickup device according to one embodiment of the
present invention, and FIG. 2 is a cross sectional view
along the line A-A shown in FIG. 1. Note that, in the
present description, the array direction or the side
direction is defined as X- or Y- direction shown in
20 FIG. 1. In addition, the diagonal direction is defined
as XY- direction shown in FIG. 1.

As shown in FIGS. 1 and 2, the solid image-pickup
device of the present invention comprises a
25 photovoltaic element 12 as a light receiving element, a
light shielding section 13, a planarized layer 14, a
color filter 15, a planarized layer 16, and an

undercoat layer 17, which are formed on a semiconductor substrate 11, a micro lens 40 including a resin lens 21c and a transparent resin layer 31, and a micro lens array 50.

5 The solid image-pickup device of the present invention is featured in particularly the constructions of the undercoat layer 17, the resin lens 21c and the transparent resin layer 31 as described in the following. It is possible to use the other
10 constituents similar in construction to those used in the ordinary solid image-pickup device.

Each of the undercoat layer 17, the resin lens 21c and the transparent resin layer 31 is formed of at least one of resins having a high transparency in the visible region and a practical reliability such as a heat resistance, a light resistance, and a resistance to heat cycles. For example, it is possible to use an acrylic resin, an epoxy resin, a polyester resin, an urethane resin, a melamine resin, a urea resin, a phenolic resin, and copolymers thereof for forming the undercoat layer 17 etc. In general, a phenolic photosensitive resin or a melamine-epoxy copolymer having a low molecular weight is used for forming the undercoat layer 17, etc.

20 It is desirable for the undercoat layer 17 to be formed of a transparent resin having an etching rate higher than that of the resin lens 21c in view of the
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manufacturing process described herein later.

As shown in FIGS. 1 and 2, the resin lenses 21c are arranged on the undercoat layer 17 to form a matrix. About square resin lenses 21c are shown in the drawings of the plain view. However, the shape of the resin lens 21 is irrelevant to the technical idea of the present invention. For example, it is possible for the resin lens 21c to be circular in the plain view.

The undercoat layer 17 serves to protect the layers positioned below the undercoat layer 17 and to hold stationary each of the resin lenses 21c. As shown in FIG. 2, the greatest feature of the undercoat layer 17 resides in that ditches 22 are formed between adjacent resin lenses 21c. The ditch 22 plays the role of preventing the transparent resin layer 31 between adjacent resin lenses 21c from becoming unduly thick in the step of forming the transparent resin layer 31 by the method described herein later.

It is desirable that the ditch 22 is formed in a depth falling within a range of between 0.05 μm and 1.5 μm .

The transparent resin layer 31 is a thin layer covering each of the resin lenses 21c and the exposed undercoat layer 17. The resin lens 21 and a part of the transparent resin layer 31 positioned to cover the resin lens 21 collectively form a micro lens 40 as shown in FIGS. 2, 3A and 3B. Specially, shown in

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FIGS. 2 and 3A, the portion of the transparent resin layer 31 formed in the ditch 22 serves to narrow the gap between adjacent micro lenses 40. Also, that portion of the transparent resin layer 31 which is positioned on the resin lens 21c serves to increase the area of the light receiving region.

It is desirable that the thickness of the transparent resin layer 31 is no more than, for example, 0.3 μm . It is easy to the thickness of the transparent resin layer 31 described above to retain the shape of the resin lens 21c and perform the narrow the gap between adjacent micro lenses 40. On the other hand, it is difficult to the transparent resin layer 31 having the thickness more than for example, 0.4 μm to reproduce the shape of the resin lens 21c and bury. This is the reason why the transparent resin layer 31 buries the gap between the adjacent resin lenses 21c to form flat, so that it is hard to perform the narrow the gap between adjacent micro lenses 40 in spite of etching treatment.

Furthermore, It is desirable that the thickness of the transparent resin layer 31 is no less than, for example, 0.01 μm because of the following reason. In general, when an organic resin thin film having a thickness not larger than 0.3 μm is formed the general coating method of a low cost such as a spin coating method, it is necessary to decrease the solid resin

ratio or markedly decrease the viscosity of the coating solution. However, if the solid resin ratio is decreased, it is impossible to form a homogeneous film when the coated solution is dried. To be more specific,

5 the resin component is agglomerated to form lands in the drying step. Alternatively, the resin solution, which is thin, is rendered unstable, with the result that the resin is already agglomerated within the solvent. Under the circumstances, according to the

10 inventors experiments, it is possible to form a uniform film in the drying the coated solution step, by the general coating method of a low cost such as a spin coating method, if the lower limit in the thickness of the transparent resin coating layer should practically

15 be 0.01 μm . Therefore, from point of view on the practice, it is desirable that the lower limit in the thickness of the transparent resin layer 31 formed by the general coating method is set 0.01 μm .

Incidentally, the thickness of the transparent resin layer 31 can be controlled by controlling the properties of the coating solution. This control of the thickness of the transparent resin layer 31 enable to adjust the smear amount and the lens aberration of micro lenses 40 to some extent. Also, in the case of employing a resin having a strong agglomeration capability as a transparent resin, it is possible to emphasize the micro lens 40 shape or to increase the

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curvature of the micro lens 40. It is also possible to control to some extent the light reflection from the lens surface by adjusting the refractive index of the transparent resin. For example, in the case of using a transparent resin having a refractive index equal to that of the resin lens 21c, the lens can be designed easily.

A description will now be given of the specific function of the ditches 22.

10 In general, the resin lens 21c is formed by
utilization of heat flow (a specific process will be
described later with reference to the steps shown in
FIGS. 4B and 4C). When the heat flow is utilized, the
resin lens 21c tends to be thinner and smoother in the
XY direction (the diagonal direction of the lens array)
shown in FIG. 1 than in the X and Y directions (the
arrangement direction of a lens array). This
phenomenon is attributable to the surface tension
acting on the surface of the molten resin in the heat
flow process. If a resin layer is patterned to form
substantially rectangular parallelepiped blocks
(FIG. 4B) and then the resin is melted in the heat flow
process, the molten resin located at the corner
portions as viewed in the XY direction (the diagonal
direction) is attracted to the center due to the
surface tension. As a result, the resin lens becomes
thin and smooth in the XY direction (the diagonal

direction of the lens array). By forming a transparent resin layer 31 on the resin lens 21c, the lens curvature of a micro lens 40 is improved in the XY direction, so that the convergence characteristic can
5 be improved in the same direction. In addition, the transparent resin helps to increase the lens area, thereby improving the opening rate. If the transparent resin is coated without forming the ditches 22, the transparent resin will fill the regions between the resin lenses 21c, widening the gap between the micro lenses 40. This phenomenon is particularly marked in
10 the X or Y direction (the arrangement direction) in which the distance between the lenses is short). However, if the ditches 22 are formed first and then
15 the transparent resin is coated, the extra transparent resin, which causes the enlargement of the gap between the micro lenses 40, flows into the ditches 22 and therefore does not widen the gap between the micro lenses 40. Hence, the gap between the lenses can be as
20 narrow as possible. As can be understood from this, the function of the ditches 22 is to prevent the transparent resin from filling the regions between the lenses, thereby attaining a narrow gap between the lenses.

25 Specially, when the transparent resin 31 covers the ditch 22, the ditch 22 extending in the side direction of the micro lens array (X- or Y- direction)

tends to be filled up more easily than the ditch 22 extending in the diagonal direction of the micro lens array (XY-direction), because the ditch 22 extending in the XY-direction is larger than the ditch 22 extending in the X- or Y- direction. Therefore, in order to control the gap between adjacent micro lenses 40 in the side direction of the micro lens array and perform the small gap between adjacent micro lenses 40, it is necessary to control the properties of the coating solution and the coating conditions. In addition, it is desirable that the depth of the ditch 22 falls within a range of between 1.5 μm and 0.05 μm in order to suppress the nonuniformity of the coating of the transparent resin. Incidentally, in the present embodiment, it is necessary to set in advance the gap in the side direction of the resin lens 21c for forming the micro lens 40 at a level not larger than 0.6 μm , e.g., at 0.5 μm to 0.3 μm .

(Control of the thickness of the transparent resin layer 31)

How to control the thickness of that portion of the transparent resin layer 31 which is positioned in the ditch 22 to decrease a noise light such as smear will now be described with reference to FIGS. 1, 3A and 3B.

Specifically, FIG. 3A is a cross sectional view along the line B-B shown in FIG. 1 showing the

undercoat layer 17 and the micro lens 40, and FIG. 3B is a cross sectional view along the line C-C shown in FIG. 1 showing the undercoat layer 17 and the micro lens 40.

5 In the solid image-pickup device, the thickness D_{xy} of the transparent resin layer 31 shown in FIG. 3B, which covers the ditch 22 extending in the diagonal direction of the micro lens array, is set smaller than the thickness D of the transparent resin layer 31 shown
10 in FIG. 3A, which extends in the side direction of the micro lens array. For example, the thickness D_{xy} of the transparent resin layer 31 shown in FIG. 3B is set smaller by about 0.4 μm than the thickness D of the transparent resin layer shown in FIG. 3A. The
15 thickness D_{xy} of the transparent resin layer 31 covering the ditch 22 in the diagonal direction can be controlled by controlling the etching amount of the undercoat layer 17 after formation of the resin lens 21c, the thickness of the transparent coating resin solution coated, and the properties of the transparent resin coating solution. According to the experiments of the inventors, it is preferable that the depth of the ditch 22 is set at, for example, 1.5 to 0.05 μm , and the thickness of the transparent resin layer 31
20 positioned on the resin lens 21c is set at, for example,
25 0.3 to 0.01 μm .

In general, the noneffective portion which does

not contribute light receiving, i.e. the surface of the portion of the transparent resin layer 31 burying the ditch 22, has a large area ratio. If the noneffective portion noted above is formed flat, the light input to
5 the noneffective portion is reflected the surface of the transparent resin layer 31. The light reflected from the surface of the noneffective portion is reflected again from the cover glass of the solid image-pickup device (not shown) and, then, is incident
10 again in the solid image-pickup device so as to cause a noise light such as smear, thereby deteriorating the characteristics of the solid image-pickup device.
However, if the thickness D_{xy} of the transparent resin layer 31 covering the ditch 22 between adjacent micro lenses 40 in the diagonal direction of the micro lens array is made smaller than the thickness D , suppressing
15 of the reflection of the light on the surface of the noneffective portion can be performed. Consequently, the characteristics of the solid image-pickup device
can be markedly improved.
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In other words, the depth of the surface of the transparent resin layer 31 in the ditch 22 in the diagonal direction from the top of the micro lenses 40 is deeper than the depth of the surface of the transparent resin layer 31 in the ditch 22 in the
25 arranging direction from the top of the micro lenses 40.

With this configuration, it is possible to improve

the light collecting effect in the diagonal direction of the micro lens 40.

Furthermore, in the solid image-pickup device of the present invention, the thickness of the transparent resin layer 31 covering the ditch 22 is controlled to perform the small gap between the adjacent micro lenses 40. Now, The gap between adjacent micro lenses is determined on the basis of the curvature of the micro or resin lenses. To be more specific, two kinds of distances are defined between the points of inflection on the curves of the lenses, and, of the two, the shorter distance represents the gap between adjacent micro lenses (the longer distance represents the size of the opening).

The thickness of the transparent resin layer 31 and the state of burying the ditch 22 with the transparent resin layer 31 after coating of the transparent resin are affected by, for example, the polarity of the solvent used, the agglomerating force of the resin used, the thixotropic properties, the presence or absence and the addition amount of a surfactant, the liquid temperature, the substrate temperature, the conditions of the undercoat layer, and the coating conditions. Specially, in order to reproduce in the sub-micron region the gap between adjacent micro lenses, it is necessary to determine the sufficient conditions. As a result of an extensive

research, the present inventors have found that it is necessary for the transparent resin layer 31 to have a thickness not larger than 0.3 μm in order to reproduce in the sub-micron region the gap between adjacent micro lenses 40 in the side direction of the micro lens array.

If the thickness of the transparent resin layer 31 exceeds 0.3 μm , the ditch 21 between adjacent resin lenses 21c is filled up too much, resulting in failure to obtain a narrow gap. Also, where the thickness of the transparent resin layer 31 is not larger than 0.03 μm , the coating solution of the resin forms a thin solution and, thus, is rendered unstable, resulting in failure to form a uniform film in the coating step.

Accordingly, with this configuration, the transparent resin layer 31 covering the resin lens 21c and the ditch 22 can be formed by a simple method of a low cost such as a spin coating of a transparent resin without relying on a costly method such as a vacuum film formation.

(General Description of Method for Manufacturing Solid image-pickup device)

The manufacturing method of the solid image-pickup device will now be described with reference to the accompanying drawings. Specifically, FIGS. 4A to 4E are cross sectional views corresponding to FIG. 2 and collectively showing the manufacturing method of the solid image-pickup device. Incidentally, the portion

ranging between the planarized layer 16 in FIG. 4A and the semiconductor substrate 11 is omitted in FIGS. 4B to 4D.

In the first step, the semiconductor substrate 11 having the photovoltaic element 12 and the light shielding portion 13 formed thereon is coated with a transparent resin solution with a spinner so as to form the planarized layer 14 having a predetermined thickness. Then, color filters 15 of red, green and blue are formed on the planarized layer 14, followed by forming the planarized layer 16 having a predetermined thickness in a manner to cover the color filters 15 and the exposed portion of the planarized layer 14 and subsequently forming the undercoat layer 17 on the planarized layer 16. Further, the upper surface of the undercoat layer 17 is coated with a photosensitive resin solution containing the base material of the resin lens with a spinner so as to form a photosensitive resin layer 21 as shown in FIG. 4A.

In the next step, a series of patterning treatments including the light exposure and development are applied to the photosensitive resin layer 21 by using a photomask having a predetermined pattern so as to form a resin pattern layer 21a on the undercoat layer 17, as shown in FIG. 4B.

Then, the resin pattern layer 21a is heated and softened at a predetermined temperature so as to form

the resin lens 21b shaped like a convex lens, as shown in FIG. 4C.

After formation of the resin lenses 21b, the undercoat layer 17 positioned between adjacent resin lenses 21b is etched by, for example, an ashing or a dry etching method with the resin lenses 21b used as a resist mask so as to form the ditches 22, as shown in FIG. 4D. It is desirable to apply a strongly anisotropic etching treatment for forming the ditches 22.

It is desirable for the depth of the ditch 22 to fall within a range of between 0.05 μm and 1.5 μm .

Also it is desirable to select a resin of the undercoat layer 17 having an etching rate higher than (for example, about three times) that of the base material of the resin lens 21b for forming the undercoat layer 17. This selection is in order to retain the shape of the resin lens 21b. Further, it is important to select a material satisfying the optical characteristics such as the refractive index as the base material of the resin lens 21b.

In the next step, the surfaces of the resin lenses 21b and the ditches 22 are coated by, for example, a spinner with a predetermined transparent resin solution so as to form the transparent resin layer 31. Note that, the transparent resin layer 31 is formed such a manner that the thickness on the resin lenses 21c, the

thickness (D) on the ditch 22 in the X- and Y-directions direction, and each of the thickness (D_{xy}) on the ditch 22 in the XY-direction direction shown in FIG. 1, is performed a predetermined thickness
5 respectively. Through the processes described above, obtained is a solid image-pickup device of the present invention comprising the micro lenses 40 and the micro lens array 50, as shown in FIG. 4E.

Incidentally, it is possible to add a surfactant
10 to the coating solution in order to improve the coating properties and the dispersion capability. It is also possible to mix a plurality of different solvents or to add another resin having a different molecular weight. Further, it is possible to apply slightly an etching
15 treatment, a plasma treatment, an ultraviolet light washing, etc. as pretreatments before the coating step.

It is characteristic of the solid image-pickup device as shown in FIG. 4E or FIG. 2 that the gap between the adjacent micro lenses 40 in the X- or Y-direction is controlled in such a manner to fall within a range of between 0.005 μm and 0.3 μm . In addition, it is important that the thickness D_{xy} of the transparent resin layer 31 between the micro lenses 40 in the XY- direction is smaller than the thickness D of the transparent resin layer 31 between the micro lenses 40 in the X- or Y- direction.
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In the manufacturing method described above, the

technology of the semiconductor level, which handles a pattern sized not larger than $0.3 \mu\text{m}$, is fully utilized, making it possible to set, for example, the gap between adjacent resin lenses 21c at $0.6 \mu\text{m}$ or less and to set
5 the thickness of the photosensitive resin layer 21 at $0.3 \mu\text{m}$ or less. As a result, a small gap between adjacent micro lenses 40 can be achieved very easily.

(Example of Manufacturing Method)

An example of the manufacturing method will now be
10 described in detail.

In the first step, the planarized layer 14, the color filter 15 and the planarized layer 16 are formed successively on the semiconductor substrate 11 having the photovoltaic element 12 and the light shielding portion 13 formed therein in advance, followed by
15 forming a layer of an epoxy series resin solution on the planarized layer 16 by a spin coating method so as to form the undercoat layer 17.

Then, a phenolic photosensitive resin solution
20 (380H: manufactured by JSR) is coated over the undercoat layer 17 by a spinner, followed by drying the coating so as to form the photosensitive resin layer 21 having a thickness of $1.2 \mu\text{m}$.

In the next step, a series of patterning
25 treatments including the light exposure and development is applied to the photosensitive layer 21 by using a photomask having a predetermined pattern so as to form

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the resin pattern layers 21a on the undercoat layer 17. The resin pattern layers 21a are formed at a pitch of 5 μm and with a gap between adjacent resin pattern layers 21a set at 0.6 μm so as to correspond to the arrangement of the photovoltaic elements 12.

Then, heating is applied at 180°C for 3 minutes on a hot plate so as to perform a heat flow treatment, thereby forming the resin lenses 21b each having a lens height of 1.5 μm on the undercoat layer 17. The gap between adjacent resin lenses 21b in the side direction is 0.4 μm .

In the next step, an oxygen gas is introduced into a dry etching apparatus to set up an inner pressure of 20 Pa within the dry etching apparatus, and an etching treatment is performed for 25 seconds with the substrate kept at room temperature and with the RF power set at 1 kW so as to form the resin lenses 21c having a lens height of 1.5 μm with the gap between adjacent resin lenses 21c set at 0.5 μm in the side direction and the ditches 22 having a depth of 0.3 μm . The resins for forming the undercoat layer 17 and the resin lens 21c are selected such that the etching rate of the undercoat layer 17 is 3 times as high as that of the resin lens 21c.

Finally, the transparent resin layer 31 having a thickness of 0.1 μm is formed on the resin lens 21c by the spin coating of a thermosetting phenolic resin

solution, thereby obtaining a solid image-pickup device comprising the micro lens array 50 consisting of a plurality of micro lenses 40 arranged with a gap of 0.1 μm set between adjacent micro lenses 40.

5 According to the experiments of the inventors, in the solid image-pickup device of the present invention thus obtained, the thickness D of the transparent resin layer 31 between adjacent micro lenses 40 in the side direction of the micro lens array 50 is found to be
10 0.5 μm . Also, the thickness D_{xy} of the transparent resin layer 31 between adjacent micro lenses 40 in the diagonal direction of the micro lens array 50 is found to be 0.1 μm . Further, the opening rate is found to be 96%, which is markedly higher than the opening rate of
15 64% for the conventional solid image-pickup device.

The sensitivity and the opening rate are remarkably improved and, at the same time, the extra reflection of the light incident obliquely on the solid image-pickup device is moderated. Therefore, a solid image-pickup device of a high image quality that permits eliminating the smear can be obtained.
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The solid image-pickup device of the present invention described above produces prominent effects as described below.

25 First of all, the micro lens array used in the solid image-pickup device of the present invention is formed by forming in advance the ditches between

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adjacent resin lenses. The ditches is formed, followed by laminating a thin resin layer having a thickness not larger than 0.3 μm , with the result that the narrow gap between the adjacent micro lenses is performed. It
5 follows that it is possible to provide a solid image-pickup device of a high precision and a high performance comprising more than 2,000,000 pixels.

Also, in the present invention, it is possible to control the thickness of the transparent resin layer
10 between adjacent micro lenses in the side direction and diagonal direction of the micro lens array, making it possible to supplement the lens function and to eliminate the noise derived from the reflected light.

Further, according to the manufacturing method of
15 the present invention, the micro lenses can be formed by the simple process such as the spin coating and the etching, making it possible to prepare the micro lenses of a high precision with a high stability and a good reproducibility. It follows that it is possible to avoid the nonuniformity that tends to be generated in
20 the manufacture of a high precision solid image-pickup device.

What should also be noted is that, in the micro lens forming process of the present invention, a costly
25 vacuum equipment is used in only the etching process (or ashing process) performed for a short time, leading to an improved through-put. It follows that a solid

image-pickup device can be manufactured with a low cost.

Additional advantages and modifications will readily occur to those skilled in the art. Therefore, the invention in its broader aspects is not limited to the specific details and representative embodiments shown and described herein. Accordingly, various modifications may be made without departing from the spirit or scope of the general inventive concept as defined by the appended claims and their equivalents.